Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/798,626	ZHANG, WEI-XIAN	
Examiner	Art Unit	
Betsey M. Hoey	1724	

SEARCHED						
SEARCHED						
Class	Subclass	Date	Examiner			
210	747					
405	128.1					
	128.5					
252	175	$\bigvee$	W			
588	901	6/16/05	BMA			
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		11/1/05	BMH			
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
210	747			
405	128.1			
	128.5			
252	175	1	1	
588	901	11/109	Emz	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
inventor name	6/16/05	BMA		
Search to date	4/1/05	BMH		
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